



Article Vacancy Defects in Ga₂O₃: First-Principles Calculations of Electronic Structure

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Abstract: First-principles density functional theory (DFT) is employed to study the electronic structure of oxygen and gallium vacancies in monoclinic bulk β -Ga₂O₃ crystals. Hybrid exchangecorrelation functional B3LYP within the density functional theory and supercell approach were successfully used to simulate isolated point defects in β -Ga₂O₃. Based on the results of our calculations, we predict that an oxygen vacancy in β -Ga₂O₃ is a deep donor defect which cannot be an effective source of electrons and, thus, is not responsible for n-type conductivity in β -Ga₂O₃. On the other hand, all types of charge states of gallium vacancies are sufficiently deep acceptors with transition levels more than 1.5 eV above the valence band of the crystal. Due to high formation energy of above 10 eV, they cannot be considered as a source of p-type conductivity in β -Ga₂O₃.

Keywords: DFT; β-Ga₂O₃; oxygen vacancy; deep donor; p-type conductivity; point defects

1. Introduction

Gallium oxide (β -Ga₂O₃), well known for its unique optical and electrical properties, as a semiconductor with a wide band gap (4.9–5.0 eV), has shown a constantly growing interest as a promising material in different fields of power electronics, optoelectronics, and photonics in recent years [1–3]. It can be said, that since the beginning of the century, β -Ga₂O₃ has undoubtedly been one of the most intensively studied materials for energy devices. This was initially caused by a large expected electric breakdown field (~8 MV/cm) for its most widespread and technologically promising monoclinic β -modification [1].

Later, as a result of extensive studies, β -Ga₂O₃ demonstrates a very wide range of different potential applications in high-power field-effect transistors [1], Schottky barrier diodes [4], solar-blind ultraviolet photodetectors [5], scintillator and phosphor materials [6–8], efficient photocatalysts [9], and so on.

A deep understanding of the influence of intrinsic point defects is necessary for the successful application of any material, including a semiconductor. Almost always, point defects directly or indirectly affect and determine the doping and compensation processes, the lifetime of charge carriers, the corresponding migration processes, as well as the efficiency of the different luminescence channels. They also contribute to and even determine the diffusion mechanisms responsible for device degradation.

Interaction and mutual influence of vacancies and dopants only complicates the picture and requires detailed and careful consideration. In the case of β -Ga₂O₃, it is assumed that oxygen vacancies, being rather shallow donors with an ionization energy of E_D ~0.04 eV, determine its behavior of n-type semiconductors [10]. However, many



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Copyright: © 2021 by the authors. Licensee MDPI, Basel, Switzerland. This article is an open access article distributed under the terms and conditions of the Creative Commons Attribution (CC BY) license (https:// creativecommons.org/licenses/by/ 4.0/). first-principle calculations devoted to the study of oxygen vacancies in β -Ga₂O₃ suggest that they are rather deep than shallow donors with charge transition levels below 1 eV from the bottom of the conduction band [11–16]. It is worth to noting that the formation energy of vacancies and, consequently, transition levels of energy in the gap strongly depend on the corresponding band gap evaluation. Proper estimation of the band gap is a major point in a way of correct evaluation of transition levels, as shown by Zacherle et al. [12] and Varley et al. [17]. In our previous hybrid B3LYP study on oxygen vacancies in β -Ga₂O₃ [18], it was shown that vacancies create deep donor levels and no have contribution to observable n-type conductivity. Other theoretical calculations have shown that, most likely, shallow donors should be attributed to H or Si impurities in β -Ga₂O₃ [17]. On the other hand, several other publications reported that Ni-, Zn-, Cu-, and N-doped β -Ga₂O₃ demonstrated p-type semiconductor characteristics [14,19–23].

In this paper, we report first-principles DFT calculations of electronic properties of oxygen and gallium vacancies (V_O and V_{Ga}) in β -Ga₂O₃. The calculated defect transition levels and corresponding defect formation energies obtained in this work are of decisive importance for direct explanation of the experimental results. Furthermore, performed detailed analysis of vibrational spectra will allow constructive identification and detection of defect-induced Raman modes, which may represent the only possibility to characterize such defects at the fundamental absorption edge of β -Ga₂O₃.

2. Computational Methods

Calculations that were performed in this work used the global hybrid functional B3LYP [24], respectively, implemented in the CRYSTAL17 program [25]. The all-electron Gaussian-type basis sets (BS) for Ga (8s-64111sp-41d) and O (8s-411sp) atoms were taken from Refs. [26,27], respectively. The total energy convergence threshold for the selfconsistent field (SCF) procedure was chosen at 10^{-7} and 10^{-9} Hartree for both structural and frequency calculations, respectively. For the geometry optimization, the quasi-Newton scheme was used, as implemented in the CRYSTAL17 code. Gradients are estimated every time the total energy is computed, the second derivative matrix (i.e., Hessian matrix) is accordingly constructed from the gradients and updated by BFGS algorithm. Optimization is considered complete when change in energy between steps is below 10^{-7} a.u. and default gradient and displacement criteria are satisfied. The effective atomic charges, as always, were determined using the Mulliken population analysis [28]. To simulate the point defects in a crystal, the periodic model of an extended unit cell (supercell) was used, and calculations were performed on 80 atoms supercell. The required different charge states of the defect were simulated by adding or removing or electrons to the supercell. To maintain electroneutrality, a compensation background charge was used. The integration of the reciprocal space was performed with a Pack-Monkhorst $4 \times 4 \times 4$ grid [29], resulting in 24 k-points.

The formation energy of a defect *D* with a charge *q* in a system *X* is defined as:

$$E_f = E_{tot}(D) - E_{tot}(X) + \sum_i n_i \mu_i + q(E_F - E_V) + E_{corr}$$
(1)

where $E_{tot}(D)$ and $E_{tot}(X)$ are the total energies of the system with and without a defect, n_i represents the number of atoms of the element *i* that are removed from the system when a defect is formed (a negative value for n_i means the addition of atoms), and μ_i is the chemical potential of the element *i* that presents the energy of atoms that are removed (or added) into the system when a corresponding defect is formed. The necessary study was carried out for both oxygen-poor and rich conditions, using molecular O_2 as a dopant source in the gas phase. The fourth term $q(E_F - E_V)$ represents a change in the electron energy due to the exchange of electrons and holes with the carrier reservoirs. $E_F - E_V$ is the Fermi energy relative to the maximum of the valence band of a defect-free system. E_{corr} are corrections which account for a defect–defect interaction and energy offset when the system is charged. We take the chemical potentials of the O_2 molecule (oxygen-rich condition) and also the metallic Ga (oxygen-poor condition) as a corresponding limiting phase. The fifth

term is a Makov–Payne correction term to compensate the artificial interaction between the periodic images of point charges [30].

For determination of the corresponding charge state transition levels for various defects, we used the approximation described by Lany and Zunger [31], based on the previous study by Scherz and Scheffler [32], stating that the transition level is the Fermi energy, at which the formation energy of a charged defect is equal to that of a neutral defect:

$$E_{tot}(D,q) - E_{tot} \quad (X) + \sum_{i} n_{i}\mu_{i} + q(\varepsilon(q/q') - E_{V})$$

= $E_{tot}(D,q') - E_{tot}(X) + \sum_{i} n_{i}\mu_{i} + q'(\varepsilon(q/q') - E_{V}) + E_{corr}$

thus

$$\varepsilon(q/q') = \frac{E_{tot}(D,q') - E_{tot}(D,q) - E_{corr}}{q-q'} + E_V$$
⁽²⁾

As usual, the zero energy reference was chosen at the top of the valence band. We considered cases in which an electronic charge is added to the system, i.e., the state q' corresponds to a state with an extra electron. Furthermore, q+1e corresponds to a transition from a neutral state to a negatively charged state, $\varepsilon (0/-1)$, or vice versa.

3. Results

3.1. Atomic and Electronic Structure of Bulk β -Ga₂O₃

It is well established that there are five crystalline modifications for Ga₂O₃, namely α , β , γ , δ , and ε , among which the β modification is the most stable under ambient conditions [1–3]. In particular, β -Ga₂O₃ has a monoclinic crystal structure, as commonly denoted as C2/m. The corresponding unit cell of β -Ga₂O₃ is shown in Figure 1, (see also [18]), where a $\perp c$, b $\perp c$, and the angle between *a* and *c* axes is 104°. The crystal lattice parameters are *a* = 12.19 Å, *b* = 3.05 Å, and *c* = 5.82 Å. It is important that there are two distinct Ga sites, shown as Ga(1) and Ga(2) (Figure 1). The Ga(1) atoms are bonded to four neighboring O atoms in a (roughly) tetrahedral arrangement, while the Ga(2) atoms are in an octahedral environment and are bonded to six neighboring O atoms. Note that not all bonds that extend to atoms in neighboring unit cells are shown in Figure 1. The O atoms have three distinct sites: O(1) and O(2) are bonded to three Ga atoms, while O(3) is combined with four Ga atoms, with the Ga–O bond lengths range from 1.8 to 2.1 Å.



Figure 1. Schematic representation of the crystal structure of monoclinic β -Ga₂O₃. Unique positions of Ga and O atoms in the lattice are shown [18].

For perfect β -Ga₂O₃, the basic bulk properties are calculated (Table 1) using various DFT functionals. As can be seen, the hybrid density functional theory methods give better agreement with experiment in terms of the energy gap E_g , cohesive energy E_{coh} , and average dielectric constants ε , than in the case of the HF method and the standard

DFT-GGA functionals, e.g., PBE. The corresponding Mulliken's analysis performed clearly showed a slight difference in the ionic charge on atoms with different positions in the crystal, which is associated with the anisotropy of the electronic properties [q(Ga1) + 1.48e, q(Ga2) + 1.58e, q(O1) = -0.994e, q(O2) = -0.997e, q(O3) = -0.079e], as well as a considerable covalency of the Ga–O bonding (~0.2e).

Table 1. Bulk characteristics of pure β -Ga₂O₃ as calculated by means of the DFT-LCAO method in this study. The lattice parameters *a*, *b*, *c* as well as band gap *Eg* values were calculated earlier and adopted from [18].

	HF	PBE	B3LYP	Exp
a, Å	12.19	12.34	12.34	12.12 ÷ 12.34 [2]
<i>b,</i> Å	3.05	3.11	3.09	3.03 ÷ 3.04 [2]
<i>c,</i> Å	5.82	5.90	5.87	5.80 ÷ 5.87 [2]
E_g , eV	13.8	2.36	4.49	4.9 [33]
E_{coh} , eV	-4.33	-7.08	-8.36	-11.3 [34]
$\varepsilon^{\infty}(average)$	2.38	3.67	3.14	3.57, 3.38, 3.53 [<mark>34</mark>]
ε^0 (average)	8.06	10.61	9.6	10.2

The apparent weakness of indirect transitions and the fact that the corresponding difference in energy between the indirect and direct gap is small actually makes β -Ga₂O₃ a direct gap material, which is consistent with the experimentally observed abrupt onset of absorption at 4.9 eV.

The B3LYP-calculated values of the optical dielectric constant ε^{∞} give refractive index 1.8 (n = $\sqrt{\varepsilon}$) for β -Ga₂O₃ at zero pressure that is in a good agreement with previous theoretical studies and well-known experimental values 1.84 [35], 1.88 [35], and 1.89 [36].

The calculated density of states and corresponding band structure of β-Ga₂O₃ are shown in Figure 2. The top of the valence and the bottom of the conduction band are consisting mainly from anionic O 2p states and cationic Ga 4s states, respectively [10,37]. We find an indirect band gap of 4.89 eV, with the valence band maximum (VBM) located near to the *M*-point, which is slightly smaller than the direct band gap of 4.91 eV at the Γ -point. The corresponding analysis of the dipole matrix elements shows that, although the vertical transitions are of the dipole-allowed type at the Γ point and at the VBM, they are about an order of magnitude weaker at the VBM and quickly decrease to 0 at the M-point [38]. The apparent weakness of the indirect transitions and the fact that the corresponding energy difference between indirect and direct gaps is small actually makes β -Ga₂O₃ a *direct*-gap material, which is in good agreement with the experimentally observed sharp absorption onset at 4.9 eV [33]. The obtained results of β -Ga₂O₃ are in good agreement with previous studies using the pseudopotential plane wave approach [33] and the full-potential linearized augmented plane wave method [12]. Good agreement of the calculated electronic and structural properties with the experimental data gives confidence in the correct prediction of the transition levels of intrinsic defects which often are not achievable from pure DFT methods due to well-known band gap errors.

In order to examine computational setup, we also calculated the elastic properties and frequencies of infra-red (IR) phonon modes of pristine β -Ga₂O₃. The elastic constants, bulk modulus, Young modulus and Shear modulus for β -Ga₂O₃ are presented in Table 2 with experimental data, while IR-active phonon modes at the Γ -point of β -Ga₂O₃ in Table 3. From the group theory analysis we know, that the decomposition of the Reducible Representation at the center of the First Brillouin Zone (k \approx 0) for β -Ga₂O₃ structure is as follows: $\Gamma = 10A_g + 5B_g + 10A_u + 5A_u$, where three modes are acoustic ($A_u + 2B_u$), so there are 12 active IR modes and 15 active Raman modes. Both calculations are in good agreement with observed experimental results. The absolute error is higher for modes in the lower part of the spectrum (up to 300 cm⁻¹), which mainly correspond to the Ga sublattice bending modes, while Ga–O stretching modes are very well reproduced.



Figure 2. Density of states and band structure of monoclinic β -Ga₂O₃, as calculated by means of B3LYP hybrid exchange–correlation functional within DFT in this study.

Table 2. Calculated elastic coefficients c_{ij} , bulk modulus B_H , Yong modulus E_H and shear modulus G_H (all in GPa) for β -Ga₂O₃ together with experimental values. The subscript H according to Voigt–Reuss–Hill notation.

	<i>C</i> ₁₁	<i>C</i> ₁₂	<i>C</i> ₁₃	<i>C</i> ₁₅	C ₂₂	C ₂₃	C ₂₅	C ₃₃
This work (B3LYP)	235.3	123.9	138	-12.8	357.2	75.8	6.9	356.5
PBESOL [39]	208	118	146	0	335	83	0	318
Exp [40]	238	130	152	-4	359	78	2	346
Exp [41]	243	128	160	-1.6	344	71	0.4	347
	C ₃₅	C ₄₄	C ₄₆	C ₅₅	C ₆₆	B_H	E_H	G_H
This work (B3LYP)	12	54.7	15.2	80.9	101.4	179	213.5	82
PBESOL [39]	19	50	9	77	96	171	192	73
Exp [40]	19	49	6	91	107	184	213	82
Exp [41]	1	48	5.6	89	104	183	210	80

Table 3. Calculated infra-red active phonon modes (in cm^{-1}) at the Γ -point of β -Ga₂O₃ crystal along with known experimental data.

Mode	This Work	[42]		[43]
Symmetry	Calc	Calc	Exp	Exp
Au(1)	173	155	154	-
Bu(1)	241	202	213	-
Bu(2)	280	260	262	272
Bu(3)	283	289	279	287
Au(2)	287	327	296	301
Bu(4)	362	365	356	357
Bu(5)	434	446	432	448
Au(3)	457	475	448	486
Bu(6)	573	589	572	573
Au(4)	664	678	663	671
Bu(7)	687	705	692	716
Bu(8)	737	753	743	774

The calculated reflection spectrum [44] was computed for direction of electric vector *E* parallel to the *b*-axis (E | |b), as shown in Figure 3. As can be seen, the spectrum is comparable with the measured spectra with wavevector $q \perp (100)$ and E | |b by Villora et al. [45] and even for another direction with $q \perp (-201)$ and E | |b by Azuhata [46]. This



Figure 3. Calculated IR reflectivity for wavevector $q \perp (100)$ and specific direction of electric vector $E \mid \mid b$. Experimental data are presented for comparison. Experimental data are reproduced from Villora et al. [45] and Azuhata et al. [46] (see text for the details).

3.2. Oxygen Vacancy

The corresponding formation energies for oxygen vacancies in three different crystallographic positions are shown in Figure 4. Neutral V_O has the lowest energy on the O(3) site. In all cases, oxygen vacancy acts as a negative-U defect, where the 1+ charge state is unstable. Obtained transition levels are ε (2+/0) = 4 eV for O(1), 3.8 eV for O(2), and 3.1 eV for O(3) (Table 4). Under oxygen-rich conditions, formation energy increases by ~2.76 eV. As seen, transition levels are located nearly 1 eV under the conduction band minimum (CBM), which is the amount of thermal energy that is much greater than the room temperature to promote an electron from the defect level to the CBM [47]. Therefore, oxygen vacancies are deep donors, i.e., the defects with high ionization barrier and are not the effective source of charge carriers. Meanwhile, as will be shown, further gallium vacancies are deep acceptors with empty levels located high enough from the top of VBM (>0.7 eV) but lower than the donors levels. Thus, oxygen vacancies can easily donate their electrons to gallium vacancies and effectively compensate positively charged defects. As acceptor doping increases, the Fermi level is pushed down toward the VB by decreasing the formation energy of oxygen vacancies as donors. On the other hand, the same process increases the formation energy of acceptors thanks to their charging beginning, thus preventing further reduction in donor formation energy. Thus, it can be assumed that the energy balance can be achieved between these two competing processes when crystal system comes close to equilibrium conditions. Finally, this leads to unchanged concentration of native donors and acceptors.

As clearly follows from Figure 5, the creation of an oxygen vacancy leads to the appearance of a corresponding defect level in the band gap. Depending on the arrangement of oxygen vacancies in the lattice, their levels occur at different heights from the top of VBM (or depths from CBM bottom). The difference between DOS defect levels confirms the disparity of the local electronic structure of each oxygen vacancy. Occupied defect states (a neutral oxygen vacancy, two electrons in the defect site) are in the middle of the band gap, thus showing the defect's high ionization potential and proving this defect as a deep donor. Therefore, the locations of the oxygen vacancy level qualitatively correlate with the calculated charge transition levels, e.g., the levels of V_{O1} lie are higher from the top of VBM than the levels of other vacancies, which indicates a more "shallow donor" nature of the defects (Figure 5).



Figure 4. Formation energies of point defects in β -Ga₂O₃ plotted against the Fermi energy for (a) oxygen-poor and (b) oxygen-rich conditions. For V_{Ga}, two different vacancies are denoted V_{Ga}(1) and V_{Ga}(2). Analogous notation is used for three oxygen vacancies. The straight vertical line shows the calculated position of the conduction band minimum.

Defect	Transition	This Work (B3LYP)	Zacherle et al. (HSE06) [12]	Varley et al. (HSE06) [13,17]
V _{O1}	2+/0	4	3	3.31
V _{O2}	2+/0	3.8	3.2	2.7
V _{O3}	2+/0	3.1	2.4	3.57
V _{Ga1}	0/1-	1.49	2	1.65
	1-/2-	1.9	2.3	2.9
	2-/3-	2.9	2.8	3.3
V _{Ga2}	0/1-	0.74	1.3	2
	1-/2-	1.43	1.8	2.5
	2-/3-	2.7	2.45	3

Table 4. Transition levels, $\varepsilon(q/q')$ (in eV), of vacancy defects in β -Ga₂O₃.

3.3. Gallium Vacancy

Gallium vacancy (V_{Ga}) is a common defect in β -Ga₂O₃. As it is well known, Ga possesses three valence electrons. Therefore, a missing Ga atom leaves behind three dangling bonds that can accept electrons and, thus, V_{Ga} can act as a triple acceptor and compensate donors, reducing free-electron concentration.

The formation energies of V_{Ga} are shown on Figure 3 at low and high oxygen chemical potentials. Indeed, as it was written above, with an increase in the chemical potential of oxygen, the formation energy of V_{Ga} decreases by ~4 eV. Corresponding calculations clearly show that the Ga(1) vacancy has a lower formation energy than Ga(2). The obtained optical transition levels (in eV) for Ga(1)/Ga(2) vacancies are: ε (0/1–) = 1.49/0.74, ε (1–/2–) = 1.9/1.43, ε (2–/3–) = 2.9/2.7. The difference in the formation energies and transition levels can be related to the anisotropy of the local electronic structure of each defect. Indeed, obtained effective charges of neutral Ga(1) and Ga(2) vacancies shows discrepancy: $q(V_{Ga1}) = +0.83e \text{ vs } q(V_{Ga2}) = +0.95e$. The essential difference between transition levels of Ga vacancies is obtained in another calculation with HSE06 hybrid functional by Zacherle [12]. The transition levels lie rather high above the VBM.



Figure 5. Total density of states for three types of V_O in β -Ga₂O₃: (**a**) for V_{O1}^0 ; (**b**) for V_{O2}^0 ; (**c**) for V_{O3}^0 (see Figure 1). V_O states have been magnified by a factor of 20.

The calculated density of states for V_{Ga}^0 (Figure 6) also shows that defect states (three holes on oxygen atoms around a vacancy) lie more than 1 eV above the top of valence band, making this defect a deep acceptor; therefore, these vacancies can serve as compensators for donor impurities only. Meanwhile, the formation energy of a neutral vacancy even at O-rich conditions equals more than 10 eV thus, the concentration of such defects under equilibrium conditions is negligible.

For comparison, we summarized transition levels of all vacancies in Table 4 with available literature data. One can see that our results are slightly higher in energy for oxygen vacancies than in the case of the hybrid HSE06 calculations of Zacherle et al. [12] or Varley et al. While, for gallium vacancies, our obtained transition energies are slightly lower. Nevertheless, obtained charge transition levels for all type vacancy defects are comparable among hybrid calculations. Recently, a semi-empiric DFTB study of native defects in β -Ga₂O₃ have been reported [48], where a very large supercell of 1120 atoms was used. With a 2-nm dimension, a large supercell essentially lowered the finite-size errors, elastic effects, and the band filling effect, which occur from interactions between charged defects. The results of the DFTB study also agree with our results and confirm other early theoretical investigations.



Figure 6. Total density of states for two types of V_{Ga} in β -Ga₂O₃: (**a**) for V_{Ga1}^0 and (**b**) for V_{Ga2}^0 . Three holes of V_{Ga} are localized on neighboring oxygens.

Meanwhile, the persistent n-type conductivity is often attributed to hydrogen incorporation into crystal. It predicted theoretically that hydrogen can be easily accumulated and stored in the crystal due to a small incorporation barrier of about 0.34 eV and strongly contribute to n-type conductivity because the shallow donor [17]. Interestingly, the same behavior of hydrogen has often been observed in other oxides, e.g., ZnO, SnO₂, In₂O₃ [49]. Thus, it is likely that hydrogen impurity could be a "hidden" source, which drastically transforms the non-conductive β -Ga₂O₃ to an n-type conductor. Note that hydrogen in oxides can present itself in different forms and have different charge states [50–54], which, in principle, complicates the overall picture for understanding.

4. Summary and Conclusions

In this study, we calculated the energetics and electronic structure of a fully optimized 80-atoms supercell of a monoclinic β -Ga₂O₃ crystal using the B3LYP hybrid exchange-correlation functional within the DFT approach. The use of the hybrid B3LYP functional makes it possible to accurately calculate the basic properties of pure β -Ga₂O₃. In addition, the calculated elasticity tensors and IR-active vibration modes are in good agreement with those measured experimentally and available from other calculations. The corresponding redistribution of the electron charge in ideal β -Ga₂O₃ indicates a noticeable covalence of the Ga–O bounds, which can be confirmed by further detailed X-ray or neutron diffraction analysis.

Due to local anisotropy of each defect, the formation energy of vacancy depends on own local electronic structure and contributes to the difference between transition levels. The formation of the oxygen vacancy in β -Ga₂O₃ leads to the presence of deep donor defects. That is why oxygen vacancies can be hardly responsible for n-type conductivity in β -Ga₂O₃ irrespective of their quite low formation energy. In this respect, we suggest that the n-type conductivity in gallium oxide is observed due to low donor impurity doping (e.g., by hydrogen) under crystal growth conditions. It is important to note that all types of gallium vacancies with different charge states are predicted to be deep acceptors with corresponding transition levels located more than 0.7 eV above the valence band and with a high formation energy of 10 eV. Our calculations also show that gallium vacancies cannot be the defining reason of p-type conductivity in β -Ga₂O₃ crystals. **Author Contributions:** Conceptualization, A.U., J.P. and A.I.P., formal analysis, A.U., A.P., V.P.; writing—original draft preparation, A.U., Z.K., A.A., Y.S.; writing—review and editing, A.P., M.Z., A.I.P.; visualization, A.U., Y.S.; project administration, A.U.; funding acquisition, A.U. and A.I.P. All authors have read and agreed to the published version of the manuscript.

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References

- 1. Higashiwaki, M.; Sasaki, K.; Kuramata, A.; Masui, T.; Yamakoshi, S. Gallium oxide (Ga₂O₃) metal-semiconductor field-effect transistors on single-crystal β-Ga₂O₃ (010) substrates. *Appl. Phys. Lett.* **2012**, *100*, 013504. [CrossRef]
- Pearton, S.J.; Yang, J.; Cary, P.H.; Ren, F.; Kim, J.; Tadjer, M.J.; Mastro, M.A. A review of Ga₂O₃ materials, processing, and devices. *Appl. Phys. Rev.* 2018, 5, 011301. [CrossRef]
- 3. Zhang, J.; Shi, J.; Qi, D.-C.; Chen, L.; Zhang, K.H.L. Recent progress on the electronic structure, defect, and doping properties of Ga₂O₃. *APL Mater.* **2020**, *8*, 020906. [CrossRef]
- 4. Konishi, K.; Goto, K.; Murakami, H.; Kumagai, Y.; Kuramata, A.; Yamakoshi, S.; Higashiwaki, M. 1-kV vertical Ga₂O₃ field-plated Schottky barrier diodes. *Appl. Phys. Lett.* **2017**, *110*, 103506. [CrossRef]
- 5. Sun, C.; Guo, D.; Wang, G.; Liu, H.; Yan, H.; Li, L.; Li, P.; Tang, W.; Guo, X.; An, Y.; et al. Fabrication of β-Ga₂O₃ thin films and solar-blind photodetectors by laser MBE technology. *Opt. Mater. Express* **2014**, *4*, 1067–1076. [CrossRef]
- Luchechko, A.; Vasyltsiv, V.; Kostyk, L.; Tsvetkova, O.; Popov, A.I. Shallow and deep trap levels in X-ray irradiated β-Ga₂O₃: Mg. Nucl. Instruments Methods Phys. Res. Sect. B Beam Interact. Mater. Atoms 2019, 441, 12–17. [CrossRef]
- Drozdowski, W.; Makowski, M.; Witkowski, M.E.; Wojtowicz, A.J.; Galazka, Z.; Irmscher, K.; Schewski, R. β-Ga₂O₃:Ce as a fast scintillator: An unclear role of cerium. *Radiat. Meas.* 2019, 121, 49–53. [CrossRef]
- 8. Blevins, J.; Yang, G. On optical properties and scintillation performance of emerging Ga₂O₃: Crystal growth, emission mechanisms and doping strategies. *Mater. Res. Bull.* **2021**, *144*, 111494. [CrossRef]
- Xu, X.; Lei, M.; Huang, K.; Liang, C.; Xu, J.C.; Shangguan, Z.C.; Yuan, Q.X.; Ma, L.H.; Du, Y.X.; Fan, D.Y.; et al. A facile route to porous beta-gallium oxide nanowires-reduced graphene oxide hybrids with enhanced photocatalytic efficiency. *J. Alloys Compd.* 2015, 623, 24–28. [CrossRef]
- 10. Binet, L.; Gourier, D.; Minot, C. Relation between electron band structure and magnetic bistability of conduction electrons in β-Ga₂O₃. *J. Solid State Chem.* **1994**, *113*, 420–433. [CrossRef]
- 11. Zhuo, Y.; Chen, Z.; Tu, W.; Ma, X.; Pei, Y.; Wang, G. β-Ga₂O₃ versus ε-Ga₂O₃: Control of the crystal phase composition of gallium oxide thin film prepared by metal-organic chemical vapor deposition. *Appl. Surf. Sci.* **2017**, *420*, 802–807. [CrossRef]
- Zacherle, T.; Schmidt, P.C.; Martin, M. Ab initio calculations on the defect structure of β-Ga₂O₃. *Phys. Rev. B*—*Condens. Matter Mater. Phys.* 2013, *87*, 1–10. [CrossRef]
- 13. Varley, J.B.; Peelaers, H.; Janotti, A.; Van De Walle, C.G. Hydrogenated cation vacancies in semiconducting oxides. *J. Phys. Condens. Matter* **2011**, 23. [CrossRef] [PubMed]
- 14. Liu, L.L.; Li, M.K.; Yu, D.Q.; Zhang, J.; Zhang, H.; Qian, C.; Yang, Z. Fabrication and characteristics of N-doped β-Ga₂O₃ nanowires. *Appl. Phys. A Mater. Sci. Process.* **2010**, *98*, 831–835. [CrossRef]
- Ma, X.; Zhang, Y.; Dong, L.; Jia, R. First-principles calculations of electronic and optical properties of aluminum-doped β-Ga₂O₃ with intrinsic defects. *Results Phys.* 2017, 7, 1582–1589. [CrossRef]
- Dong, L.; Jia, R.; Li, C.; Xin, B.; Zhang, Y. Ab initio study of N-doped β-Ga₂O₃ with intrinsic defects: The structural, electronic and optical properties. J. Alloys Compd. 2017, 712, 379–385. [CrossRef]

- Varley, J.B.; Weber, J.R.; Janotti, A.; Van De Walle, C.G. Oxygen vacancies and donor impurities in β-Ga₂O₃. *Appl. Phys. Lett.* 2010, 97, 142106. [CrossRef]
- 18. Usseinov, A.; Koishybayeva, Z.; Platonenko, A.; Akilbekov, A.; Purans, J.; Pankratov, V.; Suchikova, Y.; Popov, A.I. Ab-Initio Calculations of Oxygen Vacancy in Ga₂O₃ Crystals. *Latv. J. Phys. Tech. Sci.* **2021**, *58*, 3–10. [CrossRef]
- Xiao, W.Z.; Wang, L.L.; Xu, L.; Wan, Q.; Zou, B.S. Electronic structure and magnetic interactions in Ni-doped β-Ga₂O₃ from first-principles calculations. *Scr. Mater.* 2009, *61*, 477–480. [CrossRef]
- 20. Chao, L.; Jin-Liang, Y.; Li-Ying, Z.; Gang, Z.; Chao, L.; Jin-Liang, Y.; Li-Ying, Z.; Gang, Z. Electronic structures and optical properties of Zn-doped β-Ga₂O₃ with different doping sites. *Chin. Phys. B* **2012**, *21*, 127104. [CrossRef]
- Zhang, L.Y.; Yan, J.L.; Zhang, Y.J.; Li, T. Effects of N-doping concentration on the electronic structure and optical properties of N-doped β-Ga₂O₃. *Chin. Phys. B* 2012, 21, 67102. [CrossRef]
- 22. Feng, W.; Wang, X.; Zhang, J.; Wang, L.; Zheng, W.; Hu, P.; Cao, W.; Yang, B. Synthesis of two-dimensional β-Ga₂O₃ nanosheets for high-performance solar blind photodetectors. *J. Mater. Chem. C* **2014**, *2*, 3254–3259. [CrossRef]
- Yan, H.; Guo, Y.; Song, Q.; Chen, Y. First-principles study on electronic structure and optical properties of Cu-doped β-Ga₂O₃. *Phys. B Condens. Matter* 2014, 434, 181–184. [CrossRef]
- 24. Becke, A.D. Density-functional thermochemistry. III. The role of exact exchange. J. Chem. Phys. 1993, 98, 5648–5652. [CrossRef]
- Dovesi, R.; Erba, A.; Orlando, R.; Zicovich-Wilson, C.M.; Civalleri, B.; Maschio, L.; Rérat, M.; Casassa, S.; Baima, J.; Salustro, S.; et al. Quantum-mechanical condensed matter simulations with CRYSTAL. *Wiley Interdiscip. Rev. Comput. Mol. Sci.* 2018, 8, e1360. [CrossRef]
- 26. Pandey, R.; Jaffe, J.E.; Harrison, N.M. Ab initio study of high pressure phase transition in GaN. *J. Phys. Chem. Solids* **1994**, *55*, 1357–1361. [CrossRef]
- 27. Towler, M.D.; Allan, N.L.; Harrison, N.M.; Saunders, V.R.; MacKrodt, W.C.; Aprà, E. Ab initio study of MnO and NiO. *Phys. Rev. B* **1994**, *50*, 5041–5054. [CrossRef] [PubMed]
- 28. Mulliken, R.S. Electronic population analysis on LCAO-MO molecular wave functions. II. Overlap populations, bond orders, and covalent bond energies. *J. Chem. Phys.* **1955**, *23*, 1841–1846. [CrossRef]
- 29. Monkhorst, H.J.; Pack, J.D. Special points for Brillouin-zone integrations. Phys. Rev. B 1976, 13, 5188–5192. [CrossRef]
- Makov, G.; Payne, M.C. Periodic boundary conditions in ab initio calculations. *Phys. Rev. B* 1995, 51, 4014–4022. [CrossRef]
 [PubMed]
- 31. Lany, S.; Zunger, A. Assessment of correction methods for the band-gap problem and for finite-size effects in supercell defect calculations: Case studies for ZnO and GaAs. *Phys. Rev. B—Condens. Matter Mater. Phys.* **2008**, *78*, 235104. [CrossRef]
- Scherz, U.; Scheffler, M. Density-Functional Theory of sp-Bonded Defects in III/V Semiconductors. Semicond. Semimetals 1993, 38, 1–58. [CrossRef]
- Orita, M.; Ohta, H.; Hirano, M.; Hosono, H. Deep-ultraviolet transparent conductive β-Ga₂O₃ thin films. *Appl. Phys. Lett.* 2000, 77, 4166–4168. [CrossRef]
- He, H.; Orlando, R.; Blanco, M.A.; Pandey, R.; Amzallag, E.; Baraille, I.; Rérat, M. First-principles study of the structural, electronic, and optical properties of Ga₂O₃ in its monoclinic and hexagonal phases. *Phys. Rev. B—Condens. Matter Mater. Phys.* 2006, 74, 1–8. [CrossRef]
- Rebien, M.; Henrion, W.; Hong, M.; Mannaerts, J.P.; Fleischer, M. Optical properties of gallium oxide thin films. *Appl. Phys. Lett.* 2002, *81*, 250–252. [CrossRef]
- 36. Passlack, M.; Schubert, E.F.; Hobson, W.S.; Hong, M.; Moriya, N.; Chu, S.N.G.; Konstadinidis, K.; Mannaerts, J.P.; Schnoes, M.L.; Zydzik, G.J. Ga₂O₃ films for electronic and optoelectronic applications. *J. Appl. Phys.* **1995**, *77*, 686–693. [CrossRef]
- Von Wenckstern, H. Group-III Sesquioxides: Growth, Physical Properties and Devices. Adv. Electron. Mater. 2017, 3, 1600350. [CrossRef]
- 38. Stepanov, S.I.; Nikolaev, V.I.; Bougrov, V.E.; Romanov, A.E. Gallium oxide: Properties and applications—A review. *Rev. Adv. Mater. Sci.* 2016, 44, 63–86.
- Osipov, A.V.; Grashchenko, A.S.; Kukushkin, S.A.; Nikolaev, V.I.; Osipova, E.V.; Pechnikov, A.I.; Soshnikov, I.P. Structural and elastoplastic properties of β-Ga₂O₃ films grown on hybrid SiC/Si substrates. *Contin. Mech. Thermodyn.* 2018, 30, 1059–1068. [CrossRef]
- Miller, W.; Böttcher, K.; Galazka, Z.; Schreuer, J. Numerical Modelling of the Czochralski Growth of β-Ga₂O₃. *Crystals* 2017, 7, 26. [CrossRef]
- 41. Adachi, K.; Ogi, H.; Takeuchi, N.; Nakamura, N.; Watanabe, H.; Ito, T.; Ozaki, Y. Unusual elasticity of monoclinic β-Ga₂O₃. *J. Appl. Phys.* **2018**, *124*, 085102. [CrossRef]
- Schubert, M.; Korlacki, R.; Knight, S.; Hofmann, T.; Schöche, S.; Darakchieva, V.; Janzén, E.; Monemar, B.; Gogova, D.; Thieu, Q.-T.; et al. Anisotropy, phonon modes, and free charge carrier parameters in monoclinic β-gallium oxide single crystals. *Phys. Rev. B* 2016, *93*, 125209. [CrossRef]
- Onuma, T.; Saito, S.; Sasaki, K.; Goto, K.; Masui, T.; Yamaguchi, T.; Honda, T.; Kuramata, A.; Higashiwaki, M. Temperaturedependent exciton resonance energies and their correlation with IR-active optical phonon modes in β-Ga₂O₃ single crystals. *Appl. Phys. Lett.* **2016**, 108, 101904. [CrossRef]

- 44. Demichelis, R.; Suto, H.; Noël, Y.; Sogawa, H.; Naoi, T.; Koike, C.; Chihara, H.; Shimobayashi, N.; Ferrabone, M.; Dovesi, R. The infrared spectrum of ortho-enstatite from reflectance experiments and first-principle simulations. *Mon. Not. R. Astron. Soc.* **2012**, 420, 147–154. [CrossRef]
- Víllora, E.G.; Morioka, Y.; Atou, T.; Sugawara, T.; Kikuchi, M.; Fukuda, T. Infrared reflectance and electrical conductivity of β-Ga₂O₃. *Phys. Status Solidi Appl. Res.* 2002, 193, 187–195. [CrossRef]
- 46. Azuhata, T.; Shimada, K. Polar phonons in β-Ga₂O₃ studied by IR reflectance spectroscopy and first-principle calculations. *Appl. Phys. Express* **2017**, *10*, 081101. [CrossRef]
- 47. McCluskey, M.D. Point defects in Ga₂O₃. J. Appl. Phys **2020**, 127, 101101. [CrossRef]
- 48. Lee, J.; Ganguli, S.; Roy, A.K.; Badescu, S.C. Density functional tight binding study of β-Ga₂O₃: Electronic structure, surface energy, and native point defects. *J. Chem. Phys.* **2019**, *150*. [CrossRef]
- 49. Ágoston, P.; Albe, K.; Nieminen, R.M.; Puska, M.J. Intrinsic n-Type Behavior in Transparent Conducting Oxides: A Comparative Hybrid-Functional Study of In₂O₃, SnO₂, and ZnO. *Phys. Rev. Lett.* **2009**, *103*, 245501. [CrossRef] [PubMed]
- Kuklja, M.M.; Stefanovich, E.V.; Kotomin, E.A.; Popov, A.I.; González, R.; Chen, Y. Ab initio and semiempirical calculations of H⁻ centers in MgO crystals. *Phys. Rev. B* 1999, 59, 1885. [CrossRef]
- Zakharov, D.M.; Tropin, E.S.; Osinkin, D.A.; Farlenkov, A.S.; Porotnikova, N.M.; Ananyev, M.V. H/D isotopic exchange and electrochemical kinetics of hydrogen oxidation on Ni-cermets with oxygen-ionic and protonic electrolytes. *J. Power Sources* 2022, 517, 230708. [CrossRef]
- 52. Farlenkov, A.S.; Vlasov, M.I.; Porotnikova, N.M.; Bobrikov, I.A.; Khodimchuk, A.V.; Ananyev, M.V. Hydrogen diffusivity in the Sr-doped LaScO₃ proton-conducting oxides. *Int. J. Hydrogen Energy* **2020**, *45*, 23455–23468. [CrossRef]
- 53. Ramírez, R.; González, R.; Colera, I.; Vila, R. Protons and deuterons in magnesium-doped sapphire crystals. *J. Am. Ceram. Soc.* **1997**, *80*, 847–850. [CrossRef]
- 54. Monge, M.A.; González, R.; Popov, A.I.; Pareja, R.; Chen, Y.; Kotomin, E.A.; Kuklja, M.M. The Dynamics of the Hydride Ion in MgO Single Crystals. *Defect Diffus. Forum* **1999**, *169–170*, 1. [CrossRef]